

<b>Notice of References Cited</b>	Application/Control No. 10/529,176	Applicant(s)/Patent Under Reexamination TAKEDA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0144208	07-2004	Ando et al.	075/743
*	B	US-4,337,128	06-1982	Haakonsen et al.	205/582
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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